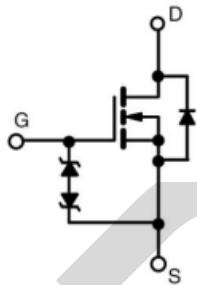


N-Channel Enhancement Mode Field Effect Transistor

MCR60F030PT

TO-247

**FRD MOSFET
ESD protect**



V_{DS}	600	V
$R_{DS(on),TYP}$	26	mΩ
I_D	80	A

Features

- 1.Low on – resistance
- 2.Package TO-247

Applications

- 1.PC power
- 2.Telcom power
- 3.Server power
- 4.EV Charger
- 5.Motor driver

Maximum ratings, at $T_A = 25^\circ\text{C}$, unless otherwise specified

Absolute Maximum Ratings

PARAMETERS/TEST CONDITIONS	SYMBOL	LIMITS	UNITS
Drain-Source Voltage	V_{DS}	600	V
Drain Current –continuous @ 25°C	I_D	80	A
Drain Current –continuous @ 100°C	I_D	48	A
Pulsed Drain Current ¹	I_{DM}	320	A
Gate-Source Voltage	V_{GS}	± 30	V
Single Pulse Avalanche ²	E_{AS}	3.5	J
Operating Junction & Storage Temperature	T_j, T_{stg}	-55 to 150	°C
Lead Temperature (1/16" from case for 10sec.)	T_L	300	°C

Note:

1. Pulse width limited by maximum junction temperature.
2. VDD = 90V, VDS = 600V, L=30mH

Electrical Characteristics

Symbol	Parameter	Condition	Min.	Typ.	Max.	Unit
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Static Electrical Characteristics @ $T_j=25^\circ\text{C}$ (unless otherwise stated)

V(BR)DSS	Drain-Source Breakdown Voltage	$V_{GS}=0\text{V}, I_D=250\mu\text{A}$	600	--	--	V
IDSS	Zero Gate Voltage Drain Current	$V_{DS}=600\text{V}, V_{GS}=0\text{V}$	--	--	10	μA
	Zero Gate Voltage Drain Current ($T_j = 125^\circ\text{C}$)	$V_{DS}=600\text{V}, V_{GS}=0\text{V}$	--	--	100	μA
IGSS	Gate-Body Leakage Current	$V_{DS}=0\text{V}, V_{GS}=\pm 30\text{V}$	--	--	± 10	nA
VGS(th)	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=250\mu\text{A}$	3	3.5	4	V
RDS(on)	Drain-Source On-State Resistance	$V_{GS}=10\text{V}, I_D=40\text{A}$	--	26	30	$\text{m}\Omega$
VSD	Forward on voltage (Note1)	$I_{SD}=80\text{A}, V_{GS}=0\text{V}$	--	1.0	1.4	V

Dynamic Electrical Characteristics @ $T_j = 25^\circ\text{C}$ (unless otherwise stated)

C_{iss}	Input Capacitance	$V_{DS}=50\text{V}, V_{GS}=0\text{V}$, $f=100\text{KHz}$	--	9140	--	pF
C_{oss}	Output Capacitance		--	884	--	pF
C_{rss}	Reverse Transfer Capacitance		--	2.4	--	pF
Q_g	Total Gate Charge	$V_{DD}=400\text{V}, I_D=40\text{A}$, $V_{GS}=10\text{V}$	--	195	--	nC
Q_{gs}	Gate-Source Charge		--	58	--	nC
Q_{gd}	Gate-Drain Charge		--	61	--	nC

Switching Characteristics

Td(on)	Turn-on Delay Time	V _{DS} =400V, I _D =40A, R _G =2Ω, V _{GS} =10V	--	41.3	--	ns
Tr	Turn-on Rise Time		--	24.6	--	ns
Td(off)	Turn-Off Delay Time		--	138.3	--	ns
Tf	Turn-Off Fall Time		--	19.8	--	ns

Source- Drain Diode Characteristics@ T_j = 25°C (unless otherwise stated)

I _S	Continuous Current		--	--	80	A
V _{SD}	Forward Voltage	I _F = I _S , V _{GS} = 0V	--	--	1.5	V
T _{rr}	Reverse Recovery Time	I _F =40A, di/dt=100A/μs	--	396	--	ns
Q _{rr}	Reverse Recovery Charge		--	3.2	--	nC
T _{on}	Forward Turn-on Time	Intrinsic turn-on time is negligible(turn-on is dominated by L _S +L _D)				

Typical Characteristics

Fig. 1

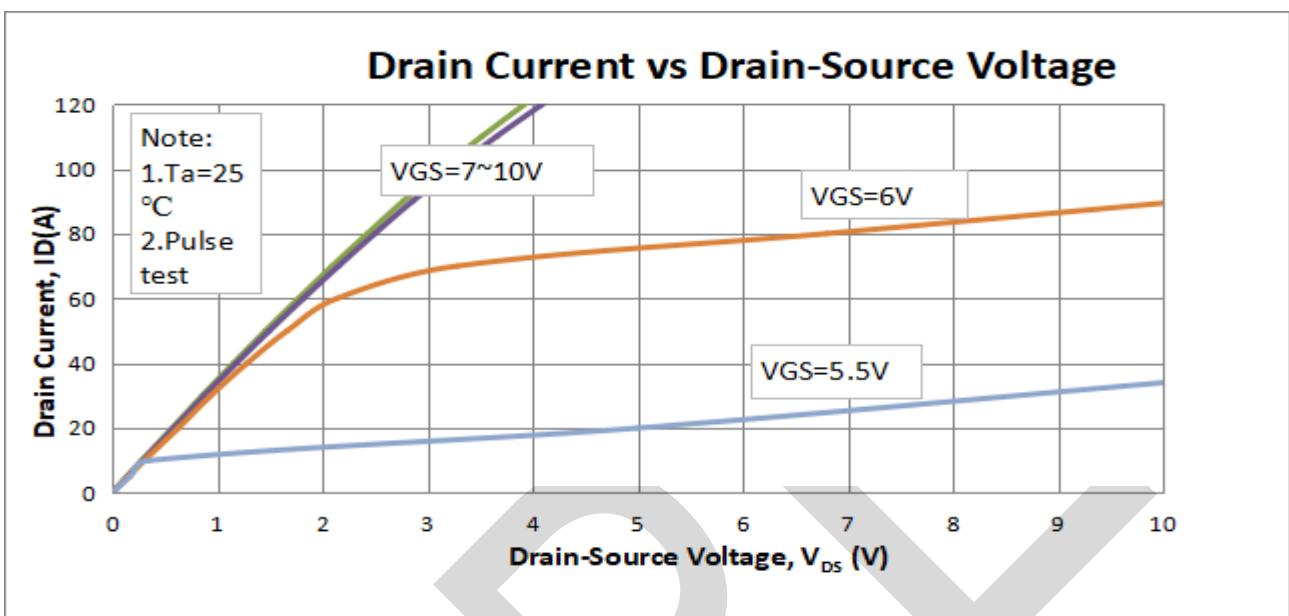
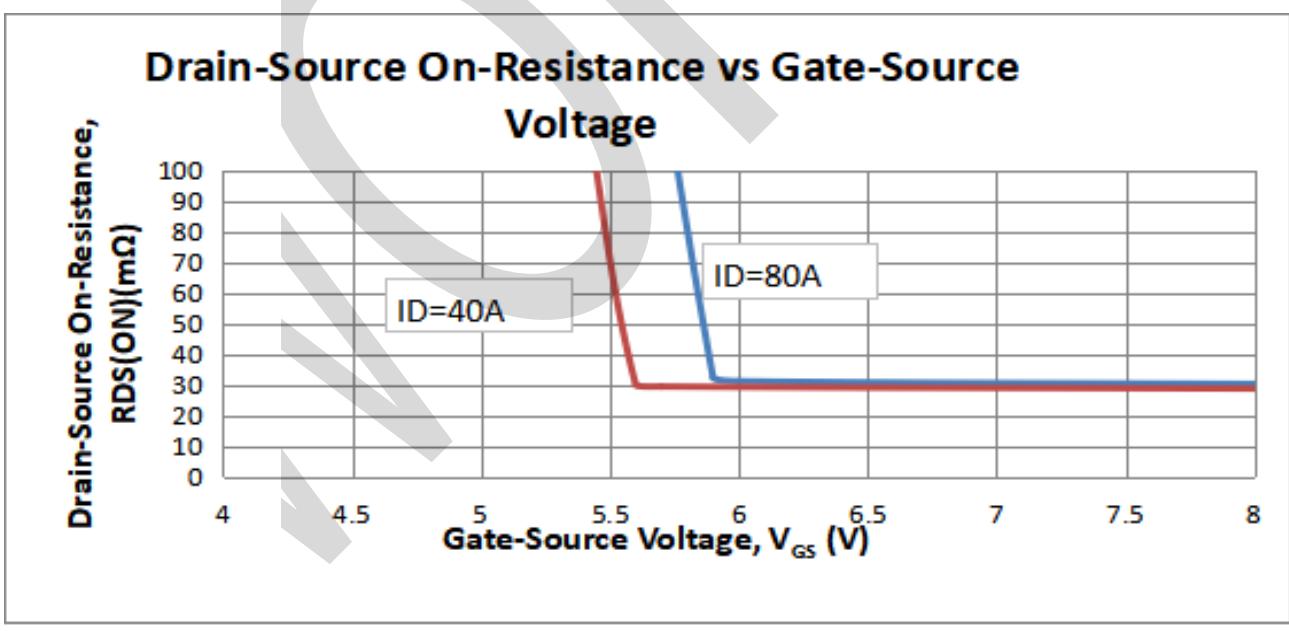


Fig. 2



Typical Characteristics

Fig. 3

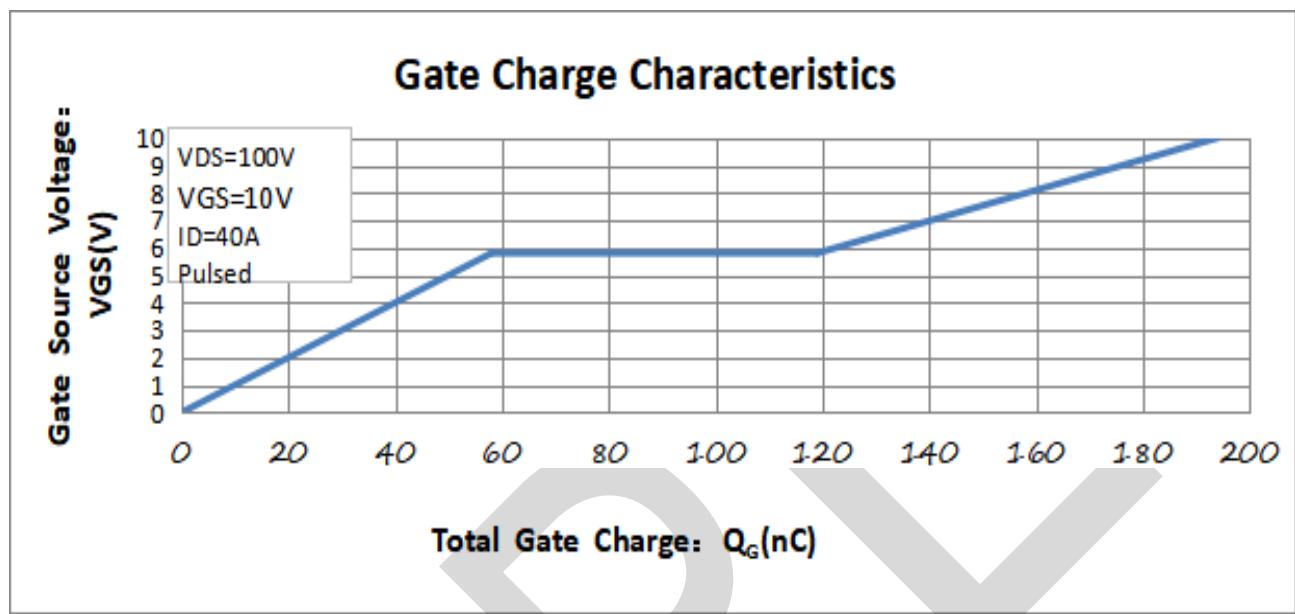
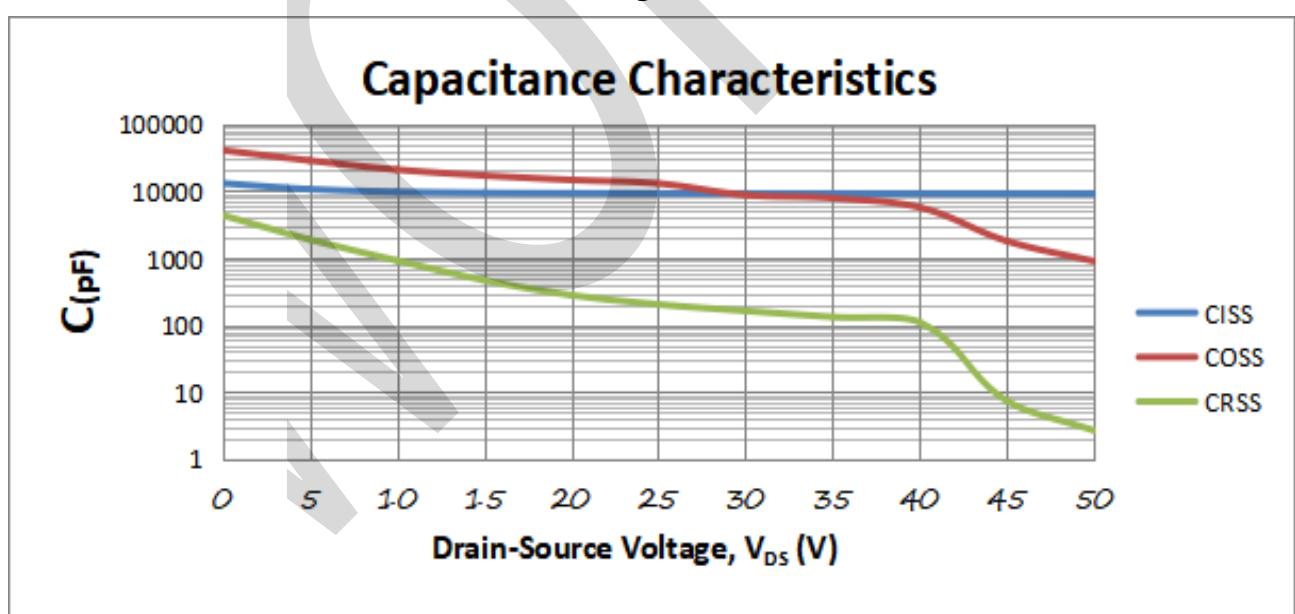


Fig. 4



Typical Characteristics

Fig. 5

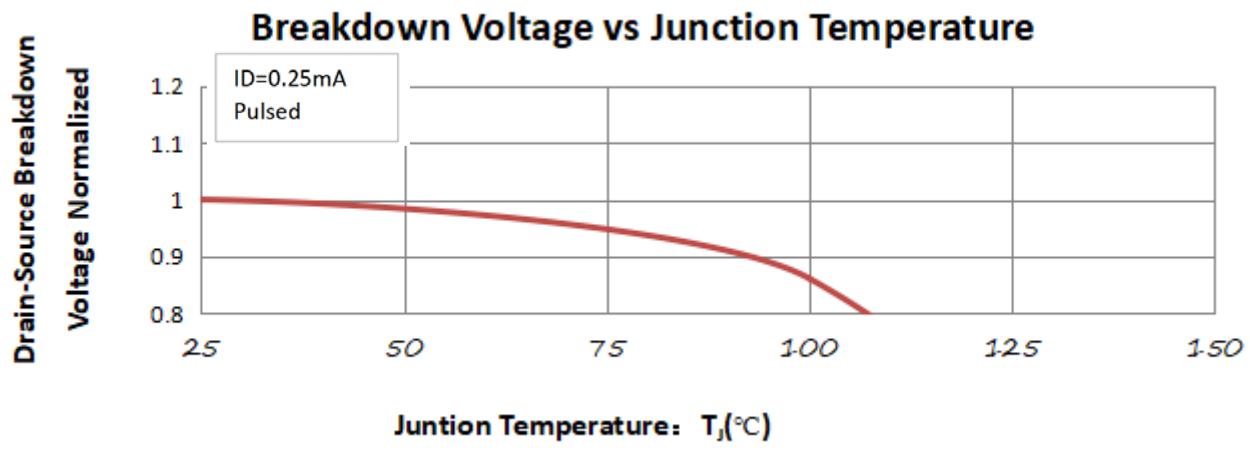
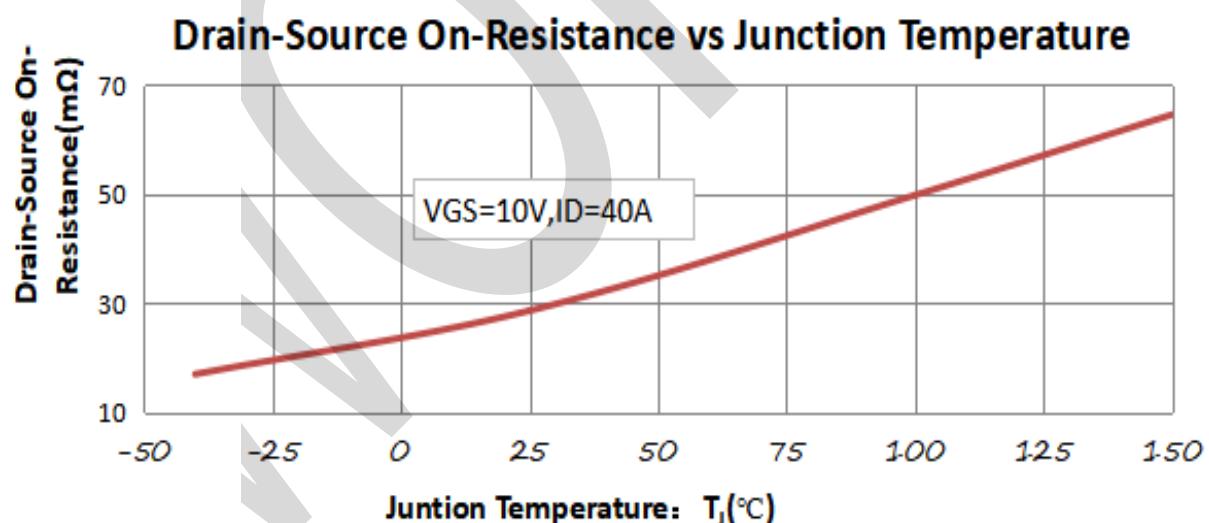


Fig. 6



Typical Characteristics

Fig.7

Gate Threshold Voltage vs Junction Temperature

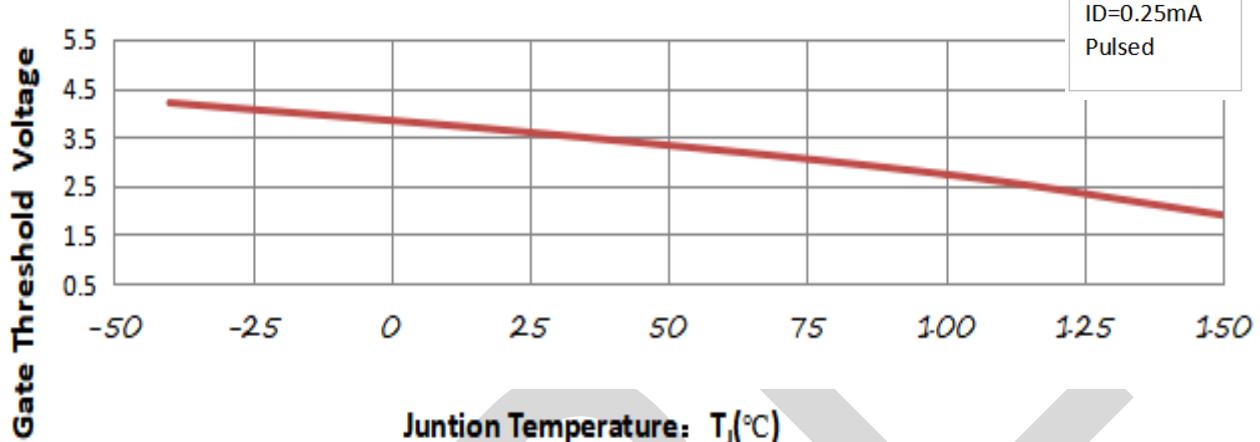
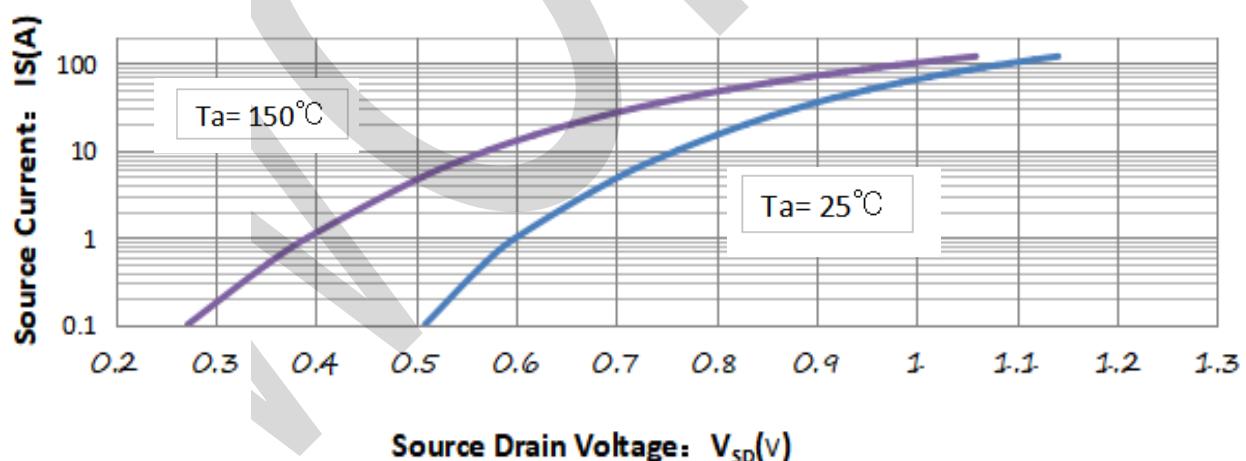


Fig. 8

Source Current vs Source Drain Voltage



Typical Characteristics

Fig. 9

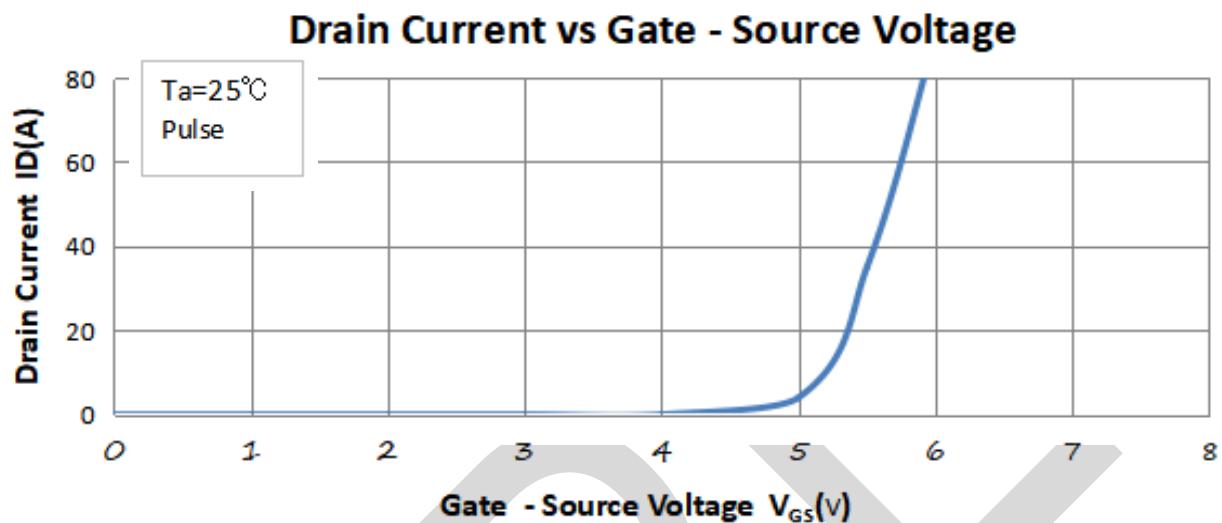
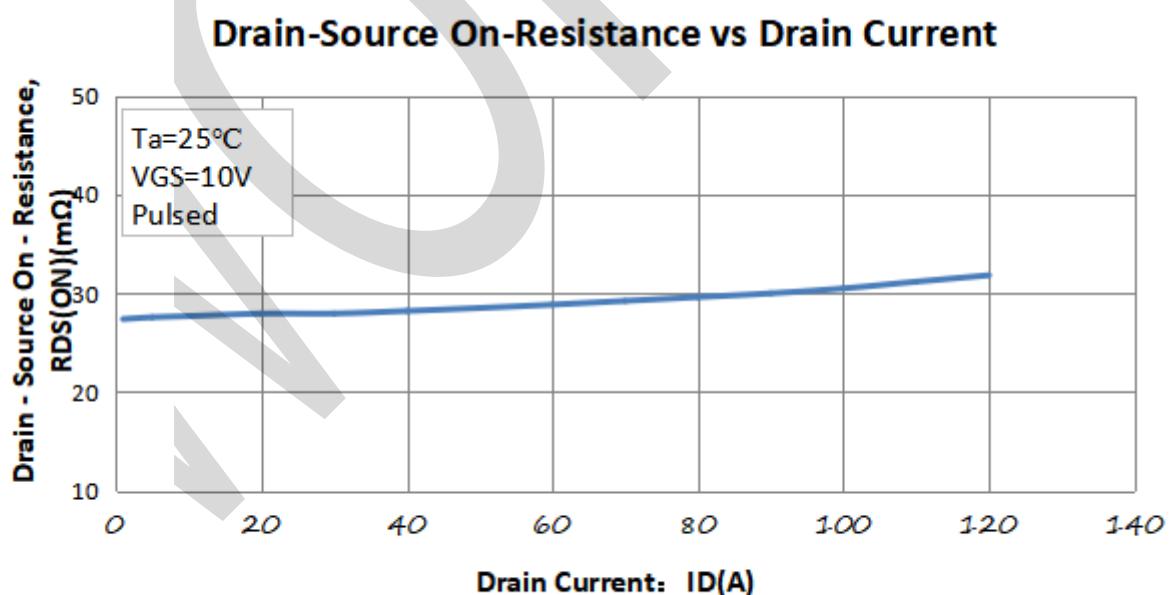


Fig. 10



PACKAGE OUTLINE DIMENSIONS

TO-247

